# **MOSFET** – Power, Single, P-Channel, Schottky Diode, **ChipFET, Schottky Barrier** -20 V, -3.0 A, 3.0 A

#### **Features**

- Leadless SMD Package Featuring a MOSFET and Schottky Diode
- 40% Smaller than TSOP-6 Package with Similar Thermal Characteristics
- Independent Pinout to each Device to Ease Circuit Design
- Ultra Low VF Schottky
- Pb-Free Package is Available

## **Applications**

- Li-Ion Battery Charging
- High Side DC-DC Conversion Circuits
- High Side Drive for Small Brushless DC Motors
- Power Management in Portable, Battery Powered Products

## MOSFET MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parai	Symbol	Value	Units		
Drain-to-Source Volt	V <sub>DSS</sub>	-20	V		
Gate-to-Source Volta	age		$V_{GS}$	±12	V
Continuous Drain	Steady	T <sub>J</sub> = 25°C	I <sub>D</sub>	-2.2	Α
Current	State	T <sub>J</sub> = 85°C		-1.6	
	$t \le 5 s$	$T_J = 25^{\circ}C$	$I_{D}$	-3.0	Α
Pulsed Drain Current	t <sub>p</sub> =	: 10 μs	I <sub>DM</sub>	-9.0	Α
Power Dissipation	Steady	$T_J = 25^{\circ}C$	$P_{D}$	1.1	W
	State	$T_J = 85^{\circ}C$		0.6	
	$t \le 5 s$	$T_J = 25^{\circ}C$		2.1	
Continuous Source C	urrent (Bo	dy Diode)	I <sub>S</sub>	-2.1	Α
Operating Junction ar Temperature	T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C		
Lead Temperature for (1/8" from case for 10		g Purposes	TL	260	°C

## SCHOTTKY DIODE MAXIMUM RATINGS

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$ 

Parameter	Symbol	Value	Units	
Peak Repetitive Reverse Voltage	$V_{RRM}$	20	V	
DC Blocking Voltage	$V_R$	20	V	



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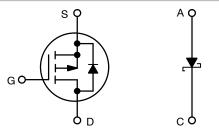
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V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> TYP	I <sub>D</sub> MAX
-20 V	–130 mΩ @ –4.5 V	-3.0 A
-20 V	200 mΩ @ -2.5 V	-0.0 A

#### **SCHOTTKY DIODE**

V <sub>R</sub> MAX	V <sub>F</sub> TYP	I <sub>F</sub> MAX
20 V	0.510 V	3.0 A



P-Channel MOSFET

**SCHOTTKY DIODE** 



ChipFET **CASE 1206A** STYLE 3

**MARKING** 

8

5

#### **PIN CONNECTIONS**

S

# **DIAGRAM** 2 င္သ 3 6

C3 = Specific Device Code

= Month Code

= Pb-Free Package

# **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTHD4P02FT1	ChipFET	3000/Tape & Reel
NTHD4P02FT1G	ChipFET (Pb-free)	3000/Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### **SCHOTTKY DIODE MAXIMUM RATINGS**

(T<sub>J</sub> = 25°C unless otherwise noted)

Paran	Symbol	Value	Units		
Average Rectified Forward Current	Steady State	T <sub>J</sub> = 25°C	IF	2.2	Α
	t ≤ 5 s			3.0	Α

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE RATINGS

	Symbol	Max	Units		
Junction-to-Ambient (Note 1)	Steady State	T 05°C	$R_{\theta JA}$	110	°C/W
	t ≤ 5 s	T <sub>J</sub> = 25°C		60	

<sup>1.</sup> Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.27 in sq [1 oz] including traces).

# MOSFET ELECTRICAL CHARACTERISTICS ( $T_J = 25$ °C unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Units
OFF CHARACTERISTICS			•	•		•
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V, } I_D = -250 \mu\text{A}$	-20	-23		V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 25^{\circ}\text{C}$			-1.0	μΑ
		$V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 85^{\circ}\text{C}$			-5.0	1
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$			±100	nA
ON CHARACTERISTICS (Note 2)						
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = -250 \mu A$	-0.6	-0.75	-1.2	V
Drain-to-Source On- Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = -4.5, I <sub>D</sub> = -2.2 A		0.130	0.155	Ω
		$V_{GS} = -2.5$ , $I_D = -1.7$ A		0.200	0.240	1
Forward Transconductance	9 <sub>FS</sub>	$V_{DS} = -10 \text{ V}, I_D = -1.7 \text{ A}$		5.0		S
CHARGES AND CAPACITANCES						
Input Capacitance	C <sub>ISS</sub>			185	300	pF
Output Capacitance	C <sub>OSS</sub>	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = -10 \text{ V}$		95	150	1
Reverse Transfer Capacitance	C <sub>RSS</sub>	DS = 10 v		30	50	1
Total Gate Charge	Q <sub>G(TOT)</sub>			3.0	6.0	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	$V_{GS} = -4.5 \text{ V}, V_{DS} = -10 \text{ V},$		0.2		]
Gate-to-Source Charge	$Q_{GS}$	I <sub>D</sub> = −2.2 A		0.5		]
Gate-to-Drain Charge	$Q_{GD}$			0.9		
SWITCHING CHARACTERISTICS (Note	: 3)					
Turn-On Delay Time	t <sub>d(ON)</sub>			7.0	12	ns
Rise Time	t <sub>r</sub>	$V_{GS} = -4.5 \text{ V}, V_{DD} = -16 \text{ V},$		13	25	
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D = -2.2 \text{ A}, R_G = 2.5 \Omega$		33	50	
Fall Time	t <sub>f</sub>			27	40	
DRAIN-SOURCE DIODE CHARACTER	ISTICS (Note 2)					
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> = -2.1 A		-0.85	-1.15	V
Reverse Recovery Time	tRR			32		ns
Charge Time	ta	V <sub>GS</sub> = 0 V, I <sub>S</sub> = -2.1 A ,		10		1
Discharge Time	tb	dl <sub>S</sub> /dt = 100 A/μs		22		1
Reverse Recovery Charge	QRR	1		15		nC

**Test Conditions** 

Min

Тур

Max

Units

SCHOTTKY DIODE ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted)

Symbol

**Parameter** 

# **MOSFET ELECTRICAL CHARACTERISTICS** ( $T_J = 25$ °C unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Units
SCHOTTKY DIODE ELECTRICAL CH	ARACTERIS	STICS (T <sub>J</sub> = 25°C unless otherwise no	ted)			
Maximum Instantaneous Forward Voltage	V <sub>F</sub>	I <sub>F</sub> = 0.1 A		0.425		V
		I <sub>F</sub> = 0.5 A		0.480		
		I <sub>F</sub> = 1.0 A		0.510	0.575	
Maximum Instantaneous Reverse Current	I <sub>R</sub>	V <sub>R</sub> = 10 V			1.0	μΑ
		V <sub>R</sub> = 20 V			5.0	
Maximum Voltage Rate of Change	dv/dt	V <sub>R</sub> = 20 V		10,000		V/ns
Non-Repetitive Peak Surge Current	legm	Halfwave, Single Pulse, 60 Hz			23	Α

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

# TYPICAL MOSFET PERFORMANCE CURVES (T<sub>J</sub> = 25°C unless otherwise noted)

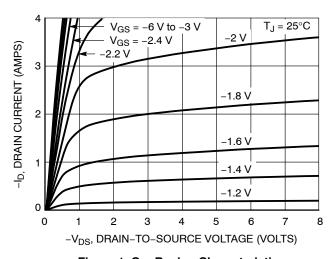


Figure 1. On-Region Characteristics

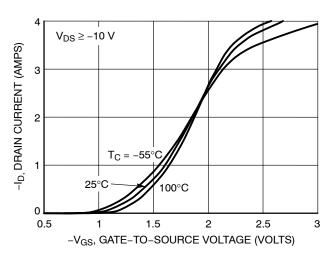


Figure 2. Transfer Characteristics

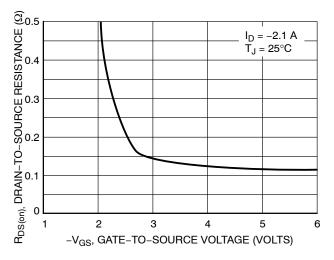


Figure 3. On-Resistance vs. Gate-to-Source Voltage

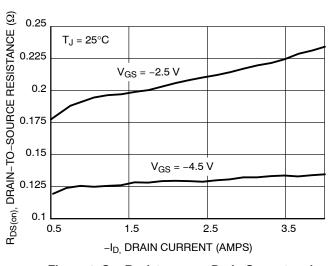


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

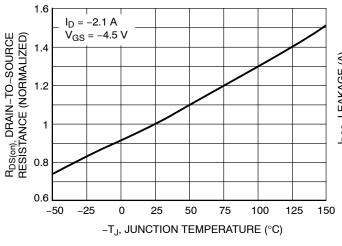


Figure 5. On–Resistance Variation with Temperature

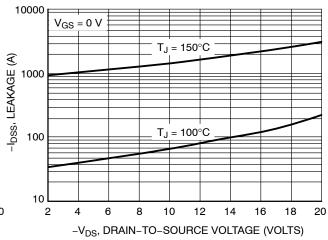


Figure 6. Drain-to-Source Leakage Current vs. Voltage

# TYPICAL MOSFET PERFORMANCE CURVES (T<sub>J</sub> = 25°C unless otherwise noted)

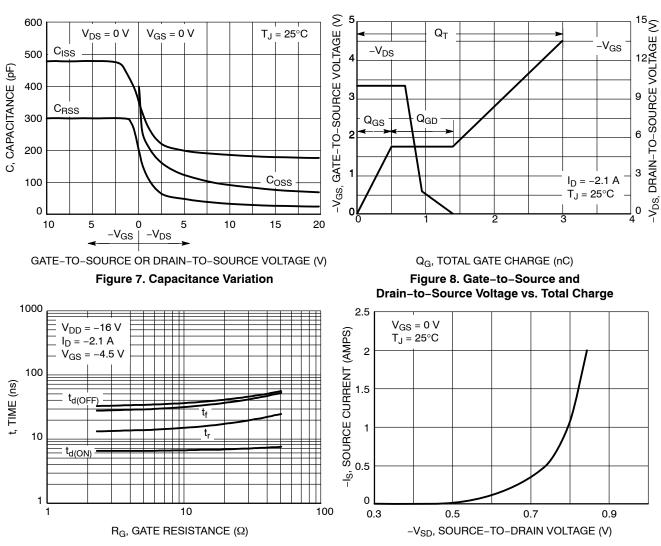


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

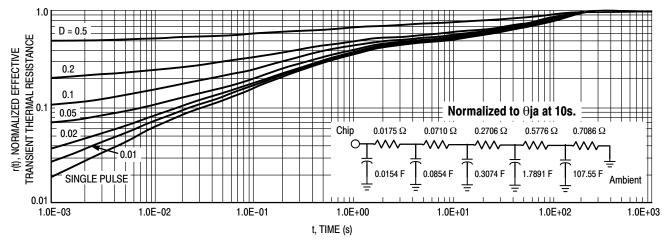
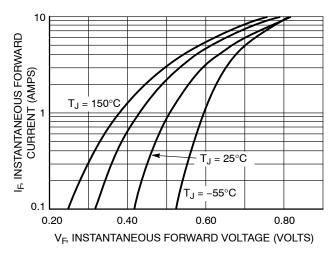


Figure 11. Thermal Response

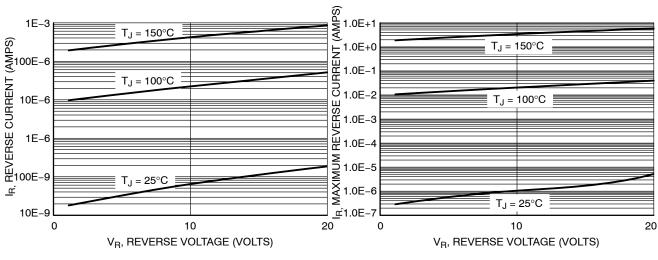
# TYPICAL SCHOTTKY PERFORMANCE CURVES (T<sub>J</sub> = 25°C unless otherwise noted)



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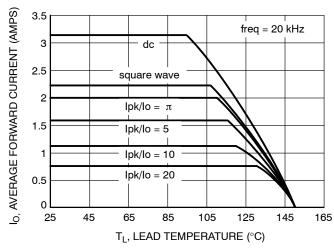
Figure 12. Typical Forward Voltage

Figure 13. Maximum Forward Voltage



**Figure 14. Typical Reverse Current** 

Figure 15. Maximum Reverse Current



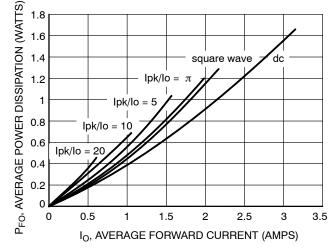


Figure 16. Current Derating

Figure 17. Forward Power Dissipation

#### **SOLDERING FOOTPRINT\***

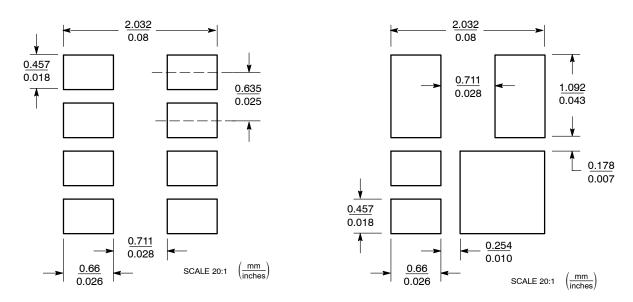


Figure 18. Basic

Figure 19. Style 3

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

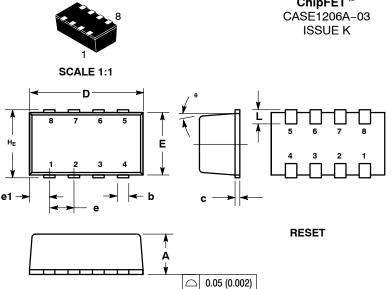
#### **BASIC PAD PATTERNS**

The basic pad layout with dimensions is shown in Figure 18. This is sufficient for low power dissipation MOSFET applications, but power semiconductor performance requires a greater copper pad area, particularly for the drain leads.

The minimum recommended pad pattern shown in Figure 19 improves the thermal area of the drain connections (pins 5, 6) while remaining within the confines

of the basic footprint. The drain copper area is 0.0019 sq. in. (or 1.22 sq. mm). This will assist the power dissipation path away from the device (through the copper lead–frame) and into the board and exterior chassis (if applicable) for the single device. The addition of a further copper area and/or the addition of vias to other board layers will enhance the performance still further.





# **ChipFET™**

**DATE 19 MAY 2009** 

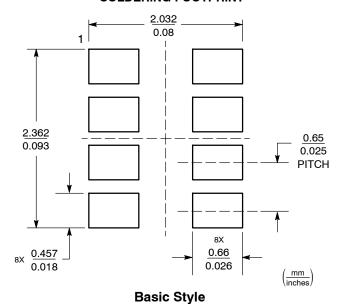
#### NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: MILLIMETER.
- MOLD GATE BURRS SHALL NOT EXCEED 0.13 MM PER SIDE. LEADFRAME TO MOLDED BODY OFFSET IN HORIZONTAL
- AND VERTICAL SHALL NOT EXCEED 0.08 MM.
  DIMENSIONS A AND B EXCLUSIVE OF MOLD GATE BURRS.
- NO MOLD FLASH ALLOWED ON THE TOP AND BOTTOM LEAD SURFACE.

	М	ILLIMETE	RS	INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	1.00	1.05	1.10	0.039	0.041	0.043	
b	0.25	0.30	0.35	0.010	0.012	0.014	
С	0.10	0.15	0.20	0.004	0.006	0.008	
D	2.95	3.05	3.10	0.116	0.120	0.122	
E	1.55	1.65	1.70	0.061	0.065	0.067	
е		0.65 BSC		0.025 BSC			
e1		0.55 BSC			0.022 BSC		
L	0.28	0.35	0.42	0.011	0.014	0.017	
HE	1.80	1.90	2.00	0.071	0.075	0.079	
θ	5° NOM				5° NOM		

STYLE 1:	STYLE 2:	STYLE 3:	STYLE 4:	STYLE 5:	STYLE 6:
PIN 1. DRAIN	PIN 1. SOURCE 1	PIN 1. ANODE	PIN 1. COLLECTOR	PIN 1. ANODE	PIN 1. ANODE
<ol><li>DRAIN</li></ol>	2. GATE 1	2. ANODE	2. COLLECTOR	<ol><li>ANODE</li></ol>	2. DRAIN
<ol><li>DRAIN</li></ol>	<ol><li>SOURCE 2</li></ol>	<ol><li>SOURCE</li></ol>	<ol><li>COLLECTOR</li></ol>	<ol><li>DRAIN</li></ol>	3. DRAIN
<ol><li>GATE</li></ol>	4. GATE 2	4. GATE	4. BASE	<ol><li>DRAIN</li></ol>	4. GATE
<ol><li>SOURCE</li></ol>	5. DRAIN 2	5. DRAIN	<ol><li>EMITTER</li></ol>	<ol><li>SOURCE</li></ol>	5. SOURCE
<ol><li>DRAIN</li></ol>	6. DRAIN 2	6. DRAIN	<ol><li>COLLECTOR</li></ol>	<ol><li>GATE</li></ol>	6. DRAIN
<ol><li>DRAIN</li></ol>	7. DRAIN 1	<ol><li>CATHODE</li></ol>	<ol><li>COLLECTOR</li></ol>	<ol><li>CATHODE</li></ol>	7. DRAIN
8. DRAIN	8. DRAIN 1	<ol><li>CATHODE</li></ol>	<ol><li>COLLECTOR</li></ol>	<ol><li>CATHODE</li></ol>	8. CATHODE / DRAIN

#### **SOLDERING FOOTPRINT**



#### **GENERIC MARKING DIAGRAM\***



XXX = Specific Device Code

М = Month Code = Pb-Free Package

(Note: Microdot may be in either location)

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

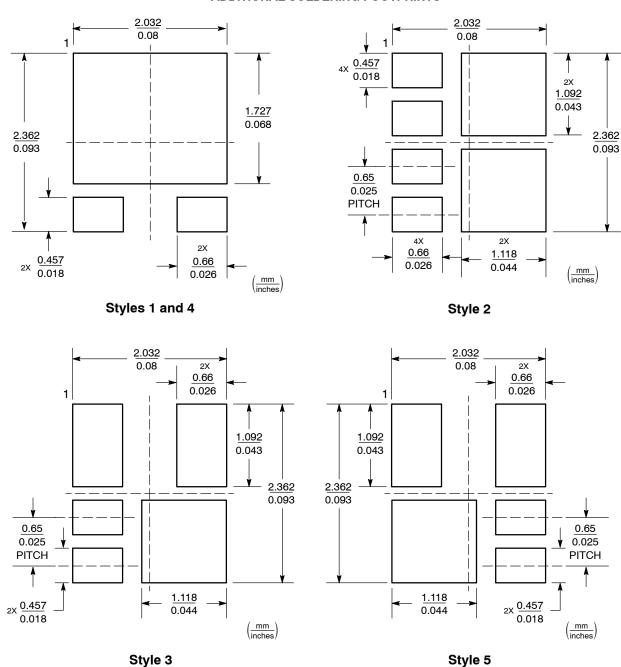
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## **ADDITIONAL SOLDERING FOOTPRINTS\***



\*For additional information on our Pb-Free strategy and soldering details, please download the **onsemi** Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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